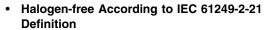


# N-Channel 30-V (D-S) MOSFET with Schottky Diode

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
30	0.0030 at V <sub>GS</sub> = 10 V	38	27.5 nC			
30	$0.0038$ at $V_{GS} = 4.5 \text{ V}$	33	27.5110			

#### **FEATURES**

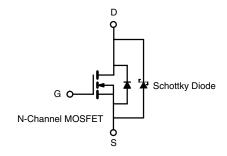


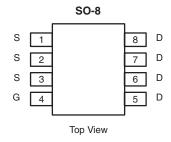


- SkyFET<sup>®</sup> Monolithic TrenchFET<sup>®</sup> Gen III Power MOSFET and Schottky Diode
- 100 %  $R_g$  and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

- Notebook CPU Core
- Buck Converter





Ordering Information: Si4628DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

ABSOLUTE MAXIMUM RATINGS $T_{ij}$	<sub>A</sub> = 25 °C, unless other	wise noted			
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		$V_{GS}$	± 20	]	
	T <sub>C</sub> = 25 °C		38		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	30		
Continuous Diain Current (1) = 150 C)	T <sub>A</sub> = 25 °C		25.4 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		20 <sup>b, c</sup>	1 ,	
Pulsed Drain Current	I <sub>DM</sub>	70	Α		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1-	7		
Continuous Source-Diam Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	3.1 <sup>b, c</sup>		
Single Pulse Avalanche Current	1 0.1 ml l	I <sub>AS</sub>	45	1	
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	101	mJ	
	T <sub>C</sub> = 25 °C	P <sub>D</sub>	7.8		
Manipular Davier Discipation	T <sub>C</sub> = 70 °C		5	100	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C		3.5 <sup>b, c</sup>	W	
	T <sub>A</sub> = 70 °C		2.2 <sup>b, c</sup>	1	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Тур.	Max.	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	29	35	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	13	16	O/ VV	

#### Notes:

- a. Based on  $T_C$  = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under Steady State conditions is 80 °C/W.



<b>SPECIFICATIONS</b> T <sub>J</sub> = 25 °C, unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	30			V	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 1 \text{ mA}$	1.0		2.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zara Cata Valtaga Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V		0.10 0.25		m A	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 100 °C		7.5	70	mA mA	
On -State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	40			Α	
	В	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		0.0024	0.0030	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$		0.0030	0.0038		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A		73		S	
Dynamic <sup>b</sup>	·	,		1	!		
Input Capacitance	C <sub>iss</sub>			3450			
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		810		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	1		260			
Total Cata Charge	0	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		58	87		
Total Gate Charge	$Q_g$			27.5	42	nC	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		8.3			
Gate-Drain Charge	$Q_{gd}$			7.5			
Gate Resistance	$R_g$	f = 1 MHz	0.4	1.7	3.4	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			28	55		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_{L}$ = 1.5 $\Omega$		20	40		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		39	75		
Fall Time	t <sub>f</sub>	1		13	26		
Turn-On Delay Time	t <sub>d(on)</sub>			12	24	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_{L}$ = 1.5 $\Omega$		10	20		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		36	70		
Fall Time	t <sub>f</sub>	1		9	18		
Drain-Source Body Diode and Schottky Characteristics							
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			7		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				70	Α	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 2 A		0.44	0.53	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			28	55	ns	
Body Diode Reverse Recovery Charge 0		1 12 A dl/dt 100 A/vo T 25 °C		21	42	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 13 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		15		1	
Reverse Recovery Rise Time	t <sub>b</sub>			13		ns	

#### Notes

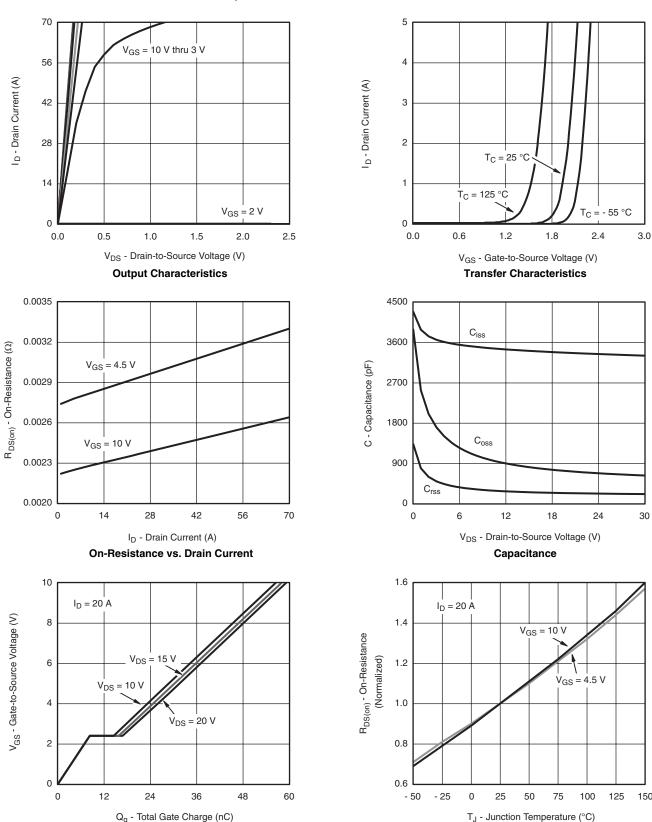
- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



**Gate Charge** 

On-Resistance vs. Junction Temperature

# VISHAY

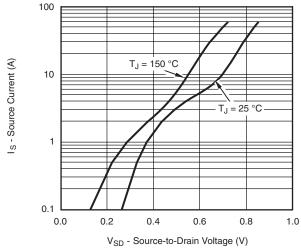
 $I_{D} = 20 \text{ A}$ 

9

 $T_J = 125$  °C

 $T_J = 25$  °C

#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





0.015

0.012

0.009

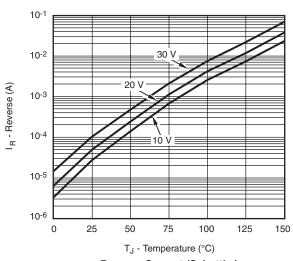
0.006

0.003

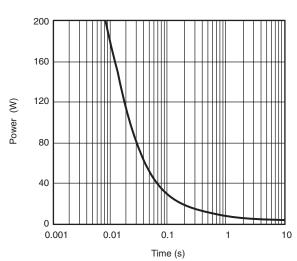
0.000

0

 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$  - On-Resistance  $(\Omega)$ 

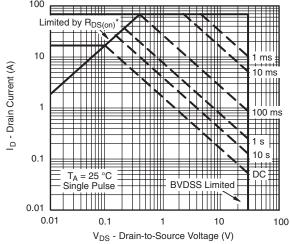


Reverse Current (Schottky)



3 4 5 6 7

Single Pulse Power, Junction-to-Ambient

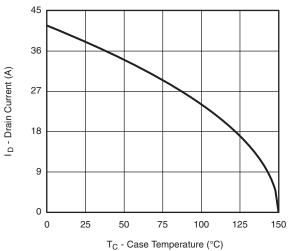


\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

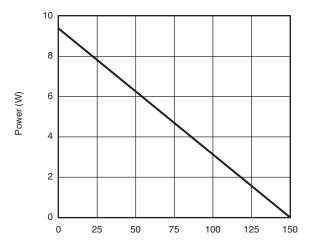
Safe Operating Area

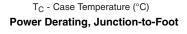


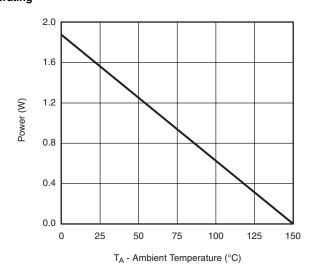
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



### Current Derating\*







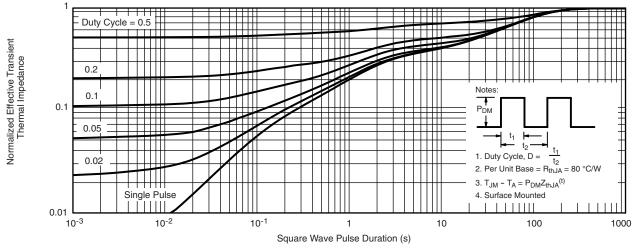
**Power Derating, Junction-to-Ambient** 

Document Number: 64811 S09-0871-Rev. A, 18-May-09

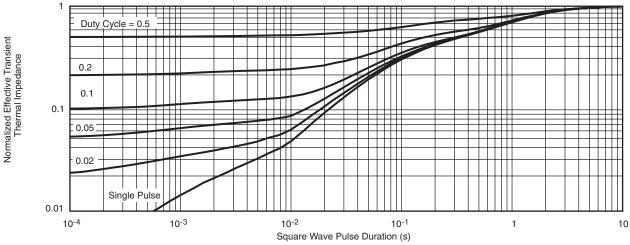
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



#### Normalized Thermal Transient Impedance, Junction-to-Ambient

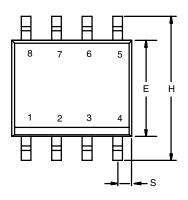


Normalized Thermal Transient Impedance, Junction-to-Foot

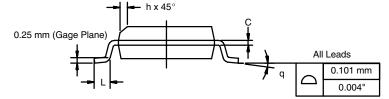
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**SOIC (NARROW): 8-LEAD** JEDEC Part Number: MS-012







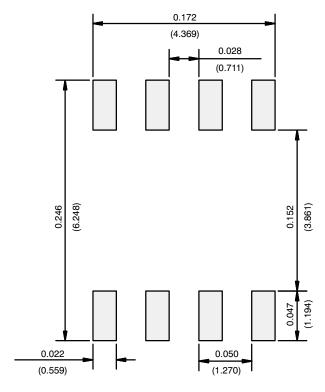
	MILLIM	IETERS	INC	HES		
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A <sub>1</sub>	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
E	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I. 11-Sep-06						

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06



#### **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)

Return to Index

APPLICATION NOT

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